

## STN3NF06L

## N-channel 60 V, 0.07 Ω 4 A, SOT-223 STripFET™ II Power MOSFET

#### **Features**

Туре	V <sub>DSS</sub> (@Tjmax)	R <sub>DS(on)</sub> max	I <sub>D</sub>
STN3NF06L	60 V	< 0.1 Ω	4 A

- Exceptional dv/dt capability
- Avalanche rugged technology
- 100% avalanche tested
- Low threshold drive

#### **Application**

Switching applications

#### **Description**

This Power MOSFET is the latest development of STMicroelectronics unique "single feature size" strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

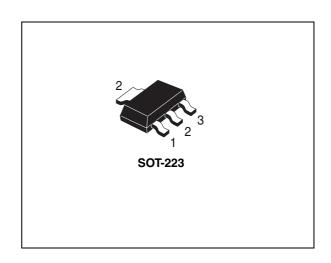


Figure 1. Internal schematic diagram

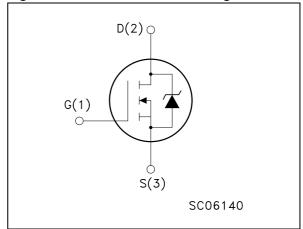


Table 1. Device summary

Order code	Order code Marking		Packaging
STN3NF06L	STN3NF06L 3NF06L		Tape and reel

Contents STN3NF06L

## **Contents**

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STN3NF06L Electrical ratings

## 1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain-source voltage (V <sub>GS</sub> = 0)	60	V
V <sub>GS</sub>	Gate-source voltage	± 16	V
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> = 25 °C	4	Α
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> =100 °C	2.9	Α
I <sub>DM</sub> <sup>(2)</sup>	Drain current (pulsed)	16	Α
P <sub>TOT</sub>	Total dissipation at T <sub>C</sub> = 25 °C	3.3	W
	Derating factor	0.026	W/°C
dv/dt (3)	Peak diode recovery voltage slope	10	V/ns
E <sub>AS</sub> (4)	Single pulse avalanche energy	200	mJ
T <sub>J</sub> T <sub>stg</sub>	Operating junction temperature Storage temperature	-55 to 150	°C

- 1. Current limited by the package
- 2. Pulse width limited by safe operating area
- 3.  $I_{SD} \leq 3$  A, di/dt  $\leq 150$  A/ $\mu$ s,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_{J} \leq T_{JMAX}$
- 4. Starting  $T_j$  = 25 °C,  $I_D$  = 4 A,  $V_{DD}$  = 30 V

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R <sub>thj-pcb</sub>	Thermal resistance junction-PCB <sup>(1)</sup> max	38	°C/W
R <sub>thj-pcb</sub>	Thermal resistance junction-PCB <sup>(2)</sup> max	100	°C/W
T <sub>I</sub> <sup>(3)</sup>	Maximum lead temperature for soldering purpose typ	260	°C

- 1. When Mounted on FR-4 board with 1 inch $^2$  pad, 2 oz. of Cu. and t <10 sec.
- 2. When mounted on minimum recommended footprint
- 3. for 10 sec. 1.6 mm from case

Electrical characteristics STN3NF06L

## 2 Electrical characteristics

(T<sub>CASE</sub> = 25 °C unless otherwise specified)

Table 4. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	$I_D = 250 \ \mu\text{A}, \ V_{GS} = 0$	60			V
I <sub>DSS</sub>	Zero gate voltage drain current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = Max rating, V <sub>DS</sub> = Max rating @125 °C			1 10	μ <b>Α</b> μ <b>Α</b>
I <sub>GSS</sub>	Gate body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ±16 V			± 100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1		2.8	V
R <sub>DS(on)</sub>	Static drain-source on resistance	$V_{GS}$ = 10 V, $I_{D}$ = 1.5 A $V_{GS}$ = 5 V, $I_{D}$ = 1.5 A		0.07 0.085	0.10 0.12	Ω Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 <sub>fs</sub> (1)	Forward transconductance	V <sub>DS</sub> = 15 V, I <sub>D</sub> =1.5 A		3		S
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS}$ =25 V, f=1 MHz, $V_{GS}$ =0		340 63 30		pF pF pF
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total gate charge Gate-source charge Gate-drain charge	$V_{DD}$ =48 V, $I_D$ = 3 A $V_{GS}$ =5 V (see Figure 15)		7 1.5 2.8	9	nC nC nC

<sup>1.</sup> Pulsed: pulse duration=300µs, duty cycle 1.5%

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub> t <sub>r</sub>	Turn-on delay time rise time	$V_{DD}$ =30 V, $I_{D}$ =1.5 A, $R_{G}$ =4.7 $\Omega$ , $V_{GS}$ =5 V (see Figure 14)		9 25		ns ns
t <sub>d(off)</sub> t <sub>f</sub>	Turn-off delay time fall time	$V_{DD}$ =30 V, $I_{D}$ =1.5 A, $R_{G}$ =4.7 $\Omega$ , $V_{GS}$ =5 V (see Figure 14)		20 10		ns ns

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
I <sub>SD</sub>	Source-drain current				4	Α
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)				16	Α
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	I <sub>SD</sub> = 4 A, V <sub>GS</sub> =0			1.5	٧
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD}$ = 4 A, di/dt = 100 A/ $\mu$ s, $V_{DD}$ =25 V, Tj=150 °C (see Figure 16)		50 88 3.5		ns nC A

<sup>1.</sup> Pulse width limited by safe operating area.

<sup>2.</sup> Pulsed: pulse duration=300µs, duty cycle 1.5%

Electrical characteristics STN3NF06L

### 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

Figure 3. Thermal impedance

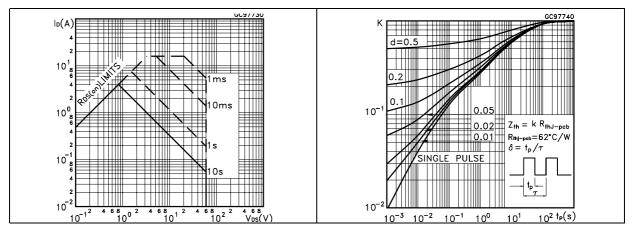


Figure 4. Output characteristics

Figure 5. Transfer characteristics

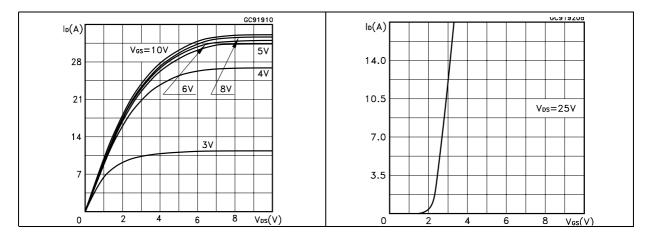


Figure 6. Transconductance

Figure 7. Static drain-source on resistance

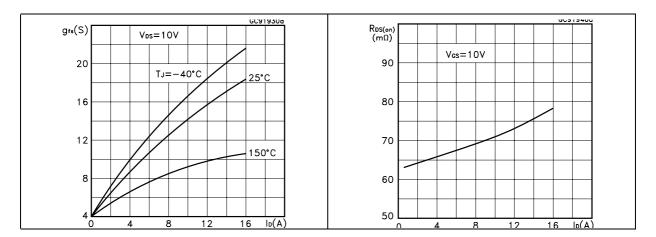


Figure 8. Gate charge vs. gate-source voltage Figure 9. Capacitance variations

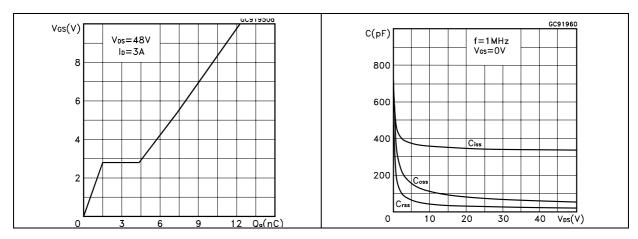


Figure 10. Normalized gate threshold voltage Figure 11. Normalized on resistance vs. vs. temperature temperature

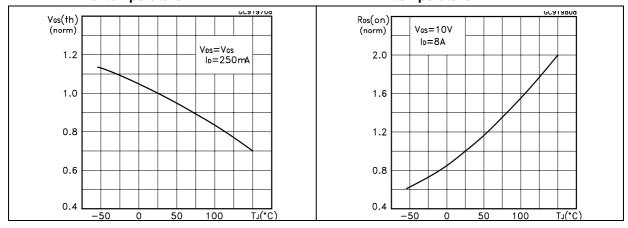
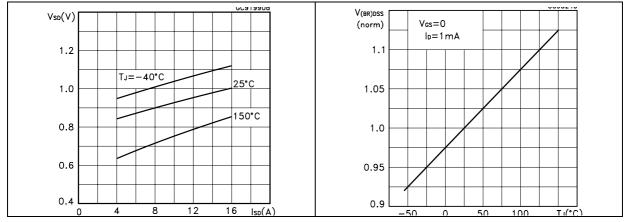


Figure 12. Source-drain diode forward characteristics

Figure 13. Normalized breakdown voltage vs. temperature



Test circuit STN3NF06L

### 3 Test circuit

Figure 14. Switching times test circuit for resistive load

Figure 15. Gate charge test circuit

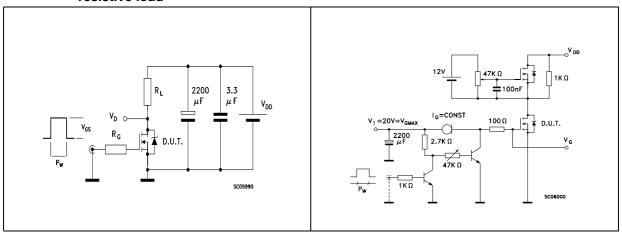


Figure 16. Test circuit for inductive load switching and diode recovery times

Figure 17. Unclamped Inductive load test circuit

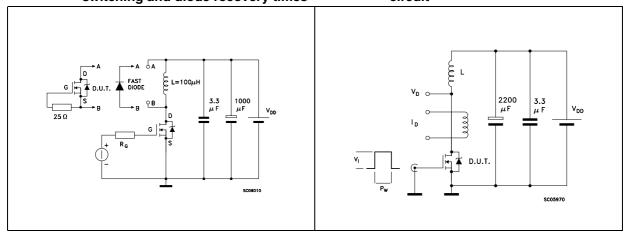
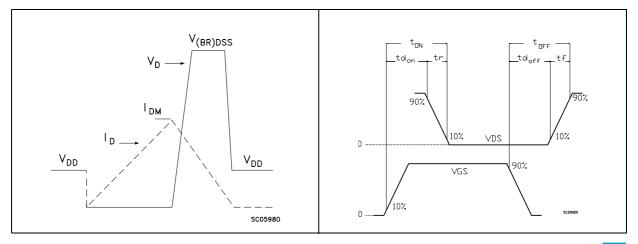


Figure 18. Unclamped inductive waveform

Figure 19. Switching time waveform



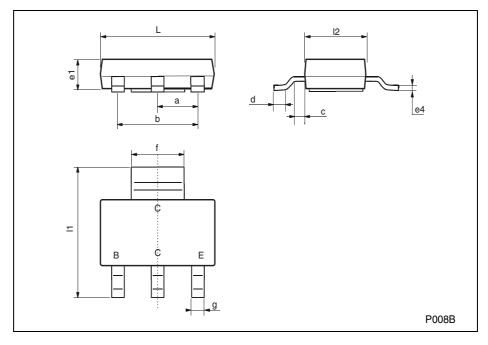
## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

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#### **SOT-223 MECHANICAL DATA**

DIM.		mm			mils	
Dim.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
а	2.27	2.3	2.33	89.4	90.6	91.7
b	4.57	4.6	4.63	179.9	181.1	182.3
С	0.2	0.4	0.6	7.9	15.7	23.6
d	0.63	0.65	0.67	24.8	25.6	26.4
e1	1.5	1.6	1.7	59.1	63	66.9
e4			0.32			12.6
f	2.9	3	3.1	114.2	118.1	122.1
g	0.67	0.7	0.73	26.4	27.6	28.7
l1	6.7	7	7.3	263.8	275.6	287.4
12	3.5	3.5	3.7	137.8	137.8	145.7
L	6.3	6.5	6.7	248	255.9	263.8



STN3NF06L Revision history

# 5 Revision history

Table 8. Document revision history

Date	Revision	Changes
21-Jun-2004	5	Complete version.
04-Oct-2006	6	New template, no content change.
01-Feb-2007	7	Typo mistake on <i>Table 2</i> .
12-Jun-2008	8	Corrected marking on Table 1

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